## Application/Control No. Applicant(s)/Patent Under Reexamination 10/692,800 MIYAKE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2181 Benjamin P. Geib **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,740,413 04-1998 Alpert et al. 712/227 Α US-В US-С US-D

## FOREIGN PATENT DOCUMENTS

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